

UNISONIC TECHNOLOGIES CO., LTD

UTT220N03 Power MOSFET

220A, 30V N-CHANNEL ENHANCEMENT MODE POWER MOSFET

■ DESCRIPTION

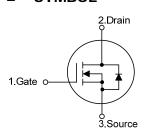
The UTC **UTT220N03** is a N-channel MOSFET, using UTC's advanced technology to provide customers with a minimum on-state resistance and superior switching performance.

The UTC **UTT220N03** is generally applied in DC to DC convertor or synchronous rectification

■ FEATURES

- * $R_{DS(ON)}$ <2.4m Ω @ V_{GS} =10V
- * Low Gate Charge (Typical 84nC)
- * Fast Switching
- * 100% Avalanche Tested
- * High Power and Current Handling Capability
- * RoHS Compliant

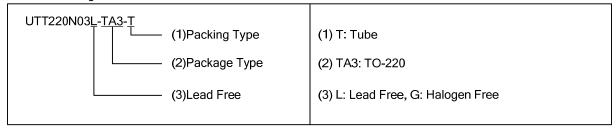
■ SYMBOL



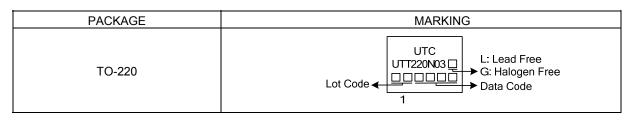
■ ORDERING INFORMATION

Ordering Number		Dealtons	Pin Assignment			Doolsing	
Lead Free	Halogen Free	Package	1	2	3	Packing	
UTT220N03L-TA3-T	UTT220N03G-TA3-T	TO-220	G	D	S	Tube	

Note: Pin Assignment: G: Gate D: Drain S: Source



■ MARKING INFORMATION



TO-220

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UTT220N03 Power MOSFET

■ **ABSOLUTE MAXIMUM RATINGS** [T_C=25°C, unless otherwise noted (Note 6)]

PARAMETER		SYMBOL	RATINGS	UNIT	
Drain-Source Voltage		$V_{ extsf{DSS}}$	30	V	
Gate-Source Voltage		V_{GSS}	±20	V	
Drain Current	Continuous (T _C =25°C)		220	Α	
	T _C =100°C	Ι _D	170	Α	
	Pulsed (Note 1)	I_{DM}	876	Α	
Single Pulsed Avalanche Energy (Note 2)		E _{AS}	864	mJ	
Peak Diode Recovery dv/dt (Note 3)		dv/dt	6.0	V/ns	
Power Dissipation	T _C =25°C		214	W	
	T _C =100°C	P_D	100	W	
	Derate above 25°C		1.43	W/°C	
Junction Temperature		T_J	-55~+175	°C	
Storage Temperature		T_{STG}	-55~+175	°C	

Note: Absolute maximum ratings are those values beyond which the device could be permanently damaged. Absolute maximum ratings are stress ratings only and functional device operation is not implied.

■ THERMAL CHARACTERISTICS

PARAMETER	SYMBOL	RATINGS	UNIT	
Junction to Ambient	θ_{JA}	62.5	°C/W	
Junction to Case	θ_{JC}	0.7	°C/W	

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■ ELECTRICAL CHARACTERISTICS (T_C=25°C, unless otherwise noted)

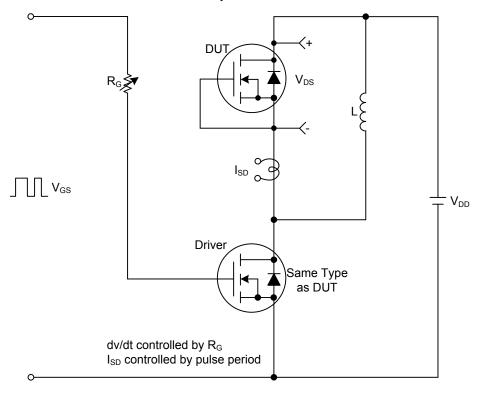
PARAMETER		SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT
OFF CHARACTERISTICS							
Drain-Source Breakdown Voltage		BV _{DSS}	I _D =250μA, V _{GS} =0V, T _C =25°C	30			V
Breakdown Voltage Temperature Coefficient		△BV _{DSS} /△T _J	Reference to 25°C, I _D =250µA		30		mV/°C
Drain-Source Leakage Current		I _{DSS}	V _{DS} =32V, V _{GS} =0V			10	μA
Gate- Source Leakage Current	Forward	1033	V _{GS} =+20V, V _{DS} =0V			+100	nA
	Reverse	I_{GSS}	V _{GS} =-20V, V _{DS} =0V			-100	nA
ON CHARACTERISTICS		ı	, 50 - , 50 -	1			
Gate Threshold Voltage		$V_{GS(TH)}$	$V_{DS}=V_{GS}$, $I_{D}=250\mu A$			3.0	V
Static Drain-Source On-State Resistance		R _{DS(ON)}	V _{GS} =10V, I _D =80A		2.0	2.4	mΩ
DYNAMIC PARAMETERS							
Input Capacitance		C _{ISS}			5490	7300	pF
Output Capacitance		Coss	V _{GS} =0V, V _{DS} =25V, f=1.0MHz		1220	1620	pF
Reverse Transfer Capacitance		C _{RSS}			155	233	pF
SWITCHING PARAMETERS							
Total Gate Charge		Q_G			200	220	nC
Gate to Source Charge		Q_GS	V _{GS} =10V, V _{DS} =30V, I _D =1.3A		19		nC
		Q_{GS2}	(Note 4, 5)		9.5		nC
Gate to Drain Charge		Q_{GD}	1		12		nC
Turn-ON Delay Time		t _{D(ON)}			58	70	ns
Rise Time		t _R	V_{DD} =30V, I_{D} =0.5A, R_{GEN} =4.7 Ω ,		260	310	ns
Turn-OFF Delay Time		t _{D(OFF)}	V _{GS} =10V (Note 4, 5)		1810	1860	ns
Fall-Time		t_{F}			987	1160	ns
Equivalent Series Resistance (G-S)		ESR			1.1		Ω
SOURCE- DRAIN DIODE RATIN	NGS AND	CHARACTERI	STICS				
Maximum Body-Diode Continuous Current		I _S				219	Α
Maximum Body-Diode Pulsed Current		I _{SM}				876	Α
Drain-Source Diode Forward Voltage		V_{SD}	I _S =80A, V _{GS} =0V			1.3	V
Body Diode Reverse Recovery Time		t _{RR}	I _S =80A, V _{GS} =0V, dI _F /dt=100A/μs (Note 4)		54		ns
Body Diode Reverse Recovery Charge		Q_{RR}			49		nC

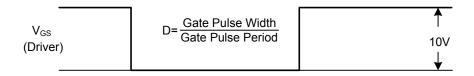
Notes: 1. Repetitive Rating: Pulse width limited by maximum junction temperature

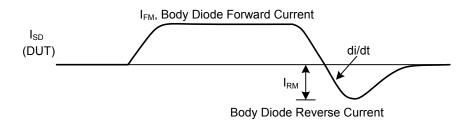
- 2. L = 3mH, I_{AS} = 24A, V_{DD} = 30V, R_G = 25 Ω , Starting T_J = 25 $^{\circ}$ C
- 3. $I_{SD} \le 80A$, di/dt $\le 200A/\mu s$, $V_{DD} \le BV_{DSS}$, Starting $T_J = 25^{\circ}C$
- 4. Pulse Test: Pulse width ≤ 300µs, Duty cycle ≤ 2%
- 5. Essentially independent of operating temperature

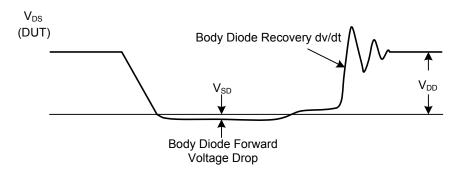
■ TEST CIRCUITS AND WAVEFORMS

Peak Diode Recovery dv/dt Test Circuit & Waveforms



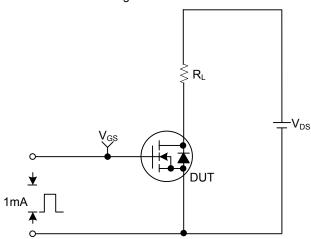




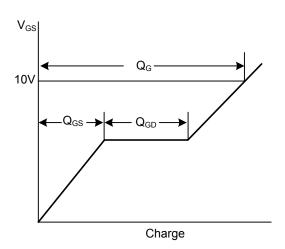


■ TEST CIRCUITS AND WAVEFORMS(Cont.)

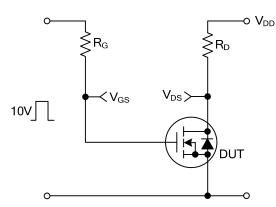
Gate Charge Test Circuit



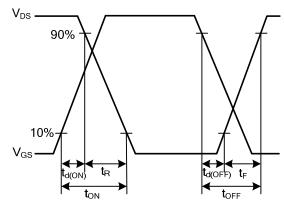
Gate Charge Waveforms



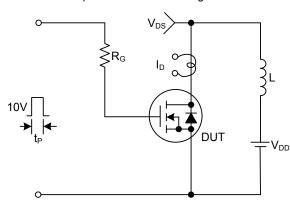
Resistive Switching Test Circuit



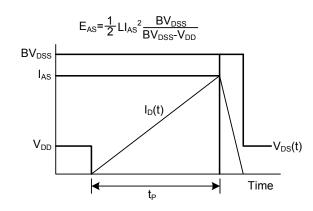
Resistive Switching Waveforms



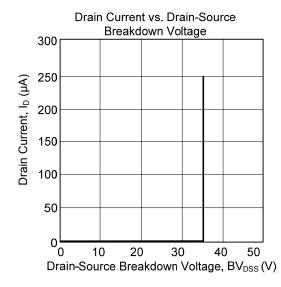
Unclamped Inductive Switching Test Circuit

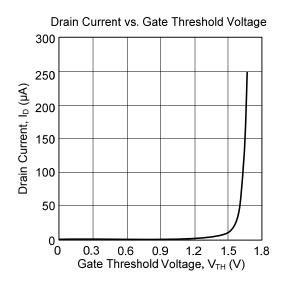


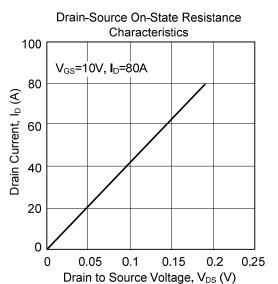
Unclamped Inductive Switching Waveforms

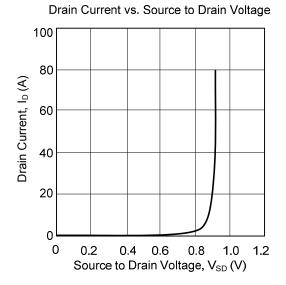


■ TYPICAL CHARACTERISTICS









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